

**Search Notes**

Application/Control No.

10/089,327

Examiner

EDMUND H. LEE

Applicant(s)/Patent under  
Reexamination

WATANABE ET AL.

Art Unit

1732

**SEARCHED**

Class	Subclass	Date	Examiner
updated		11/22/2005	EHL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR